

# Index of Claims



Application/Control No.

10/601,872

Examiner

Dah-Wei D. Yuan

Applicant(s)/Patent under  
Reexamination

CHOI ET AL.

Art Unit

1745

✓	Rejected
=	Allowed

-	(Through numeral) Cancelled
+	Restricted

N	Non-Elected
I	Interference

A	Appeal
O	Objected

Claim		Date		Claim		Date		Claim		Date	
Final	Original			Final	Original			Final	Original		
	1	✓			51				101		
	2	✓			52				102		
	3	✓			53				103		
	4	✓			54				104		
	5	N			55				105		
	6	N			56				106		
	7	N			57				107		
	8	N			58				108		
	9	N			59				109		
	10	N			60				110		
	11	N			61				111		
	12	N			62				112		
	13	✓			63				113		
	14	✓			64				114		
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